# Plant Leaf Meshes from Time-of-Flight RGB-D Sensors

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# **Abstract**

#### 1. Introduction

This paper addresses the problem of automatically building 3D mesh models of plant leafs using inexpensive time-of-flight RGB-D sensors. Plant researchers, seeking to understand genetic underpinnings of plant growth [REF] and seeking to develop new varieties [REF], need automated ways to non-invasively measure plant phenotypes including growth, leaf distributions, orientations, photosynthesis and productivity [REF]. An important step in estimating all of these properties is obtaining 3D shape and pose for all the plant leafs. Plants cannot be moved or disturbed in growth chambers, and so our concept is to mount close-range RGB-D sensors in the chambers and acquire 3D mesh models of the leafs.

Time-of-flight RGB-D sensors have both advantages and drawbacks compared to other 3D sensors. [Expand the below]

- Dense depth image without scanning or rotating the target
- Depth even on non-textured regions
- Closely-aligned high resolution color image
- Near IR reflectance image
- Significantly higher depth error than laser scanners
- Short range and sensitive to specular artifacts
- Occlusion boundary artifacts (as with most ranging devices)

Here we address a key obstacle in obtaining accurate leaf models: the large noise in the depth images. [Expand the below:]

• There has been research in merging depth maps from multiple views and in reducing noise this way. This is

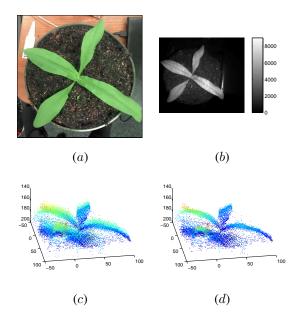


Figure 1. Illustration of sensor data. (a) Portion of color image. (b) IR reflectance image with reflectance values. (c) Portion of a single depth image surrounding plant projected into 3D showing significant depth noise. (d) Average of 60 depth images projected into 3D, with  $\sigma_S$  being the dominant source of noise. Units of 3D plots are mm. The goal of this paper is to combine these data elements into

not so helpful here as the sensor is fixed, and the size of the noise compared to the features we want to observe is large in our application.

• More ...

Our solution is a new mesh generation algorithm that leverages the high resolution color image, the dense depth estimates and the near-IR reflection image to overcome large depth errors. The paper is organized as follows. [Explain]

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#### 2. Related Work

# 3. Sensor Data Characterization

We explore using a new class of RGB-D sensor such as the Creative Senz3D [4] to build 3D mesh models of plant leafs. The sensor contains a high resolution color camera  $(1280 \times 720 \text{ pixels})$  adjacent and parallel to a lower resolution depth camera ( $320 \times 240$  pixels). A flash IR emitter adjacent to these cameras illuminates the scene and depth sensor measures the time-of-travel for the reflected light as well as its reflectance over its pixel grid. These modalities are illustrated in Figure 1. It operates in a similar way to the Kinect 2 but is designed for closer range targets.

While the sensor produces dense depth measurements over target leaf surfaces, the noise in depth measurements is significantly larger than the features we are seeking to recover as illustrated in Figure 1(c). A key goal in this paper is to overcome this noise to maximize the accuracy of leaf shape estimates. We start in this section by modeling and quantifying the measurement noise.

#### 3.1. Noise Characterization

Since the depth camera returns an IR reflectance in addition to a depth value at each pixel, both it and the color camera are initially calibrated using Zhang's method [6] to obtain intrinsic and extrinsic parameters. Thus each pixel in each camera defines a ray from its camera origin. Depth noise is modeled as a one dimensional random variable,  $\varepsilon$ , along the ray for each pixel along its ray direction.

The depth noise,  $\varepsilon$ , is modeled as the sum of an imagevarying term,  $\varepsilon_I$ , and a scene-varying term,  $\varepsilon_S$ :

$$\varepsilon = \varepsilon_I + \varepsilon_S. \tag{1}$$

The term  $\varepsilon_I$  models the random change in depth for camera pixels of subsequent images of a static scene from a static camera. To quantify this term we measured the standard deviation  $\sigma_I$  in depth of each pixel for a batch of 300 images of a fixed scene containing a flat matte surface. We repeated this at different poses and depths, and with different surface albedos. While target depth, inclination, albedo, and pixel position are all correlated with  $\sigma_I$ , we found that the best predictor for  $\sigma_I$  was the IR reflectance intensity, as shown in Figure 2. For typical scenes the single measurement noise in depth is roughly 5mm, although for low reflectivity objects or objects at long range this noise can increase significantly. Fortunately plant leafs are good IR reflectors.

Averaging depth measurements of a fixed scene will reduce the noise from  $\varepsilon_I$ , but will not reduce the noise from  $\varepsilon_S$ . This latter scene-varying term is constant for a static scene, but changes when the scene changes. To characterize this noise we first eliminated (approximately) the imagevarying noise contribution by averaging over a large number of images (300). Then assuming  $\varepsilon_S$  is independent

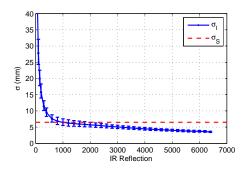


Figure 2. Image-varying noise,  $\sigma_I$ , is predicted well by the IR reflectance in raw units returned by the camera, see Figure 1(b). The scene-varying noise,  $\sigma_S$ , is plotted for comparison.

and identically distributed between pixels, we measured the variance of the pixel depth errors between a known flat surface and the estimated surface. In our experiments we obtained  $\sigma_S = 6.5mm$ , and found that it was insensitive to changes in depth.

The total pixel noise can be estimated assuming independence of  $\varepsilon_I$  and  $\varepsilon_S$ , and is given by:

$$\sigma^2 = \frac{\sigma_I^2}{N} + \sigma_S^2,\tag{2}$$

where N is the number of images averaged over. When averaging 5 or more depth images the scene-varying contribution,  $\sigma_S^2$ , will dominate. There are additional sources of noise not modeled by this. These include object specularities, and mixed-depth pixels on object edges. These tend to produce very large image-varying noise,  $\sigma_I$ , and we can filter these points by discarding depth pixels with  $\sigma_I > 20$ mm.

# 4. Mesh Fitting

We pose mesh fitting to 3D point data as finding the most likely surface that would have generated those points. By incorporating prior surface assumptions, the fitting process estimates a continuous surface from discrete points that can eliminate much of the measurement noise. Methods that fit mesh models to 3D points often minimize the perpendicular distance of points to facets [REF]. This makes sense when point-cloud noise is equal in all directions or else the point noise is small compared to the facets. For our data the measurement noise is large and is not equal in all directions, but rather is along the depth camera rays. Hence the focus of this section is to develop a mesh fitting method that minimizes these pixel depth errors along the pixel rays.

In this paper we define a mesh in a 2D image space and project it into 3D. This is more limiting than full 3D meshes as it models only the surface portions visible from the sensor, but it also provides a number of advantages. Compared

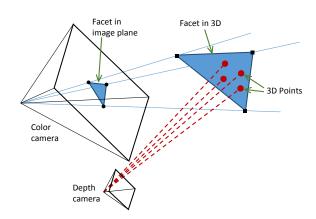


Figure 3. The parallel and adjacent color and depth cameras are shown as pyramids denoting their fields of view, and their size difference illustrates their relative resolutions. Three vertices in a color image define the rays on which the vertices of the corresponding 3D object facet must lie. This facet is fit using the the 3D points projected out from the depth camera.

to methods that fit prior surface models to depth maps [ref], need to search of the space of poses, scales and distortions of the model with the chance of finding local minima. Compared to voxel-based models with implicit surfaces [ref], our method can better incorporate pixels uncertainties and surface priors, as well as having fewer discretization artifacts. In addition our method can naturally incorporate detailed features from the high-resolution color camera, and reflectivity information from the IR reflectance image.

#### 4.1. Notation

A vertex, v, is a vector in 3D. In a given camera coordinate system, it projects onto a pixel on the unit focal-length image-plane  $\tilde{v}=(u,v,1)^{\top}$ , where the " $\tilde{v}$ " indicates a homogeneous vector, and u and v are the coordinates in this plane. Now  $\tilde{v}$  defines a ray from the camera origin, and the original vertex is obtained by scaling the image-plane vertex by its depth,  $\lambda$ , along the ray, namely:  $v=\lambda \tilde{v}$ .

#### 4.2. Facet Model

Mesh fitting for an individual facet is illustrated in Figure 3. The 2D vertices and edge connections are determined in an image, in this case the color image although it could be the depth image, as described in section 5. If these vertices lie on a feature of the target leaf, such as its edge, we know that that those 3D features like somewhere along the rays emanating from camera origin through those vertices. Hence a triangular facet approximation to the object surface will have vertices on these three rays.

The next step is to associate depth measurements with the facet. Pixels in the depth camera are projected along their rays out into 3D. The resulting 3D points that lie within

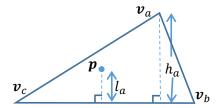


Figure 4. The coordinates of a point on a facet described by Eq. (3) are the weighted linear sum of the three vertex coordinates. The weight,  $\alpha_a$ , for vertex  $v_a$  is given by  $\alpha_a = \frac{l_a}{h_a}$ , the ratio of its perpendicular distance  $l_a$  to the opposite edge to the vertex perpendicular distance  $h_a$ . Analogous expressions describe  $\alpha_b$  and  $\alpha_c$ .

the facet pyramid (defined by these rays through its vertices) will project into the 2D facet in the color image. Hence it is straightforward to associate 3D points with mesh facets.

To estimate the facet parameters from depth measurements we will express the depth points as a linear function of the vertices of its facet. We make a local orthographic approximation for the projection of a facet. This will be a good approximation as long as the facet size is small compared to is depth from the camera, which is true for most applications. Given this assumption, the coordinates of a point p lying on a facet can be expressed as a linear combination of the three vertex coordinates  $v_a$ ,  $v_b$  and  $v_c$  as follows:

$$\boldsymbol{p} = \alpha_a \boldsymbol{v}_a + \alpha_b \boldsymbol{v}_b + \alpha_c \boldsymbol{v}_c. \tag{3}$$

The coefficients  $\alpha_a$ ,  $\alpha_b$  and  $\alpha_c$  are defined in Figure 4. Substituting in depth-scaled homogeneous vectors, and taking the third row, we obtain an equation for the point depth,  $\lambda_p$ :

$$\lambda_p = \alpha_a \lambda_a + \alpha_b \lambda_b + \alpha_c \lambda_c, \tag{4}$$

where  $\lambda_a$  is the depth of  $\boldsymbol{v}_a$  and so forth.

# 4.3. Least Squares Depth

Equation (4) gives the depth of one point in terms of its facet vertices. For mesh with many facets and a measurement with many depth points, a vector of pixel depths,  $\lambda_d$ , and vector of vertex depths,  $\lambda_v$ , are related with a coefficient matrix, A, containing the appropriate  $\alpha$ 's:

$$\lambda_d = A\lambda_v. \tag{5}$$

Given a measurement vector of point depths,  $\bar{\lambda}_d$ , expressed in the color camera coordinates, the error vector between these depths and the corresponding mesh points is:  $\bar{\lambda}_d - A\lambda_v$ . Notice that this error is along the color camera rays which to a good approximation are parallel to the depth camera rays, and thus the noise model in Eq. (2) applies. This justifies the following weighted squared error formulation:

$$E_{depth} = ||W\bar{\lambda}_d - WA\lambda_v||^2, \tag{6}$$

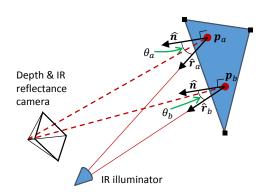


Figure 5. Our geometric model for the reflectance image. At each depth point the intensity of the reflectance image will depend on a number of factors including the angle between the facet normal and the ray to the illuminator shown for two points as  $\theta_a$  and  $\theta_b$ .

where W is a diagonal matrix containing the inverse standard deviation,  $\sigma^{-1}$ , from Eq. (2).

# 4.4. Shape from Shading

The depth camera measures IR reflectance in addition to depth at each pixel. Since the reflectance depends on the angle between the surface normal and the incident ray from the IR illuminator, the reflectance image can provide useful cues on the object surface. Shape from shading techniques model this dependence on the surface normal, along with additional surface assumptions such as smoothness, to estimate the normals and integrate an object surface [REF]. However the real world practicality of these methods has been limited since they generally require a single known light source position illuminating a Lambertian surface, the integration is sensitive to noise, and shape is obtained only up to a scale factor. Fortunately our application satisfies the key requirements of Shape from Shading, (we have a known light source and leafs are modeled well as Lambertian surfaces [1]), and our mesh model provides additional information that removes the need to integrate noisy surface normals. This section describes our use of Shape from Shading to improve shape recovery.

## 4.4.1 Reflectance Modeling

We build a simplified bidirectional reflectance model to explain the pixel values,  $R_i$ , of the IR reflectance image, shown in Figure 1(b). This model for pixel i is:

$$R_i = \frac{I_i}{r_i^h} \hat{\boldsymbol{r}}_i \cdot \hat{\boldsymbol{n}}_i \rho s_i. \tag{7}$$

Here  $I_i$  is the intensity of the ray from the IR illuminator. For a source emanating in all directions this would

decrease with a factor of  $\frac{1}{r_i^2}$ , but a focused beam the decrease may be less, and we model the decay power with h. Under a Lambertian assumption the reflected beam is given by  $\hat{r}_i \hat{n}_i \rho = \cos(\theta_i) \rho$  where  $\theta_i$  is the angle between the ray to source  $\hat{r}_i$  and the surface normal  $\hat{n}_i$ , and  $\rho$  is the albedo. Finally the sensor scales the incoming beam with a factor  $s_i$ . This model can be simplified further by merging some of the unknown parameters. We define a pixel gain  $g_i = \log(I_i \rho s_i)$ , and the resulting model is:

$$R_i = \frac{\exp(g_i)\cos(\theta_i)}{r_i^h}.$$
 (8)

The unknown parameters in Eq. 8 are  $g_i$  and h, and they can be calibrated as follows. Depth and reflectance images are taken of a flat, uniform albedo target at various depths and inclinations.

#### 4.5. Regularization

Prior models on surface properties can be incorporated into the mesh via regularization and in so doing reduce the impact of noise. Membrane energy is a well-used function in mesh optimization [3] and can be minimized using the discrete Laplacian operator. Here we use Laplacian smoothing due to its simplicity and good performance [3, 5, 2], although we modify it to accommodate image-based edge information. In addition, rather than apply Laplacian smoothing after the fact, entailing an iterative optimization [3], we show that Laplacian smoothing can be incorporated directly into the least squares mesh estimation. This has a number of advantages over application after the initial mesh estimation. First the smoothing penalty is traded off against measurement error rather than vertex offset. Second, the due to our ray constraints on the vertices we are able to derive a linear solution with not need to iterate. Finally when the regularization components are added to Eq. (6) they ensure that the solution is well-posed even when some of the facets have no depth points in them.

Laplacian smoothing uses an umbrella-operator [3] on a vertex, v, and its neighbors  $v_i \in \mathcal{N}(v)$ ,

$$\boldsymbol{u}(\boldsymbol{v}) = \frac{1}{n} \sum_{\boldsymbol{v}_i \in \mathcal{N}} \boldsymbol{v}_i - \boldsymbol{v}, \tag{9}$$

for n neighbors as illustrated in Figure 6. In our model the vertices lie along known rays and so this operator can be expressed as a function of the vertex depth:  $\mathbf{u}(\lambda) = \frac{1}{n} \sum_{i \in \mathcal{N}} \lambda_i \tilde{\mathbf{v}}_i - \lambda \tilde{\mathbf{v}}$ . The squared magnitude  $\|\mathbf{u}(\lambda)\|^2$  is a natural penalty term as it captures a discrete form of the membrane energy. Summing this over all vertices and arranging the known  $\tilde{\mathbf{v}}$  components into a single matrix U, we obtain

$$E_{reg} = ||U\boldsymbol{\lambda}||^2. \tag{10}$$



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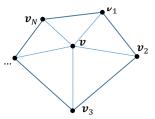


Figure 6. In discrete form the Laplacing is implemented as an umbrella operator, Eq. (9), over a vertex v and its first neighbors.

# 5. Mesh Initialization

### 6. Results

## 7. Conclusion

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